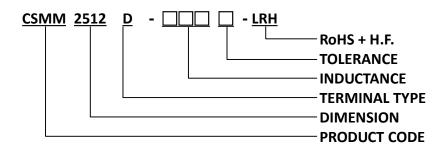


PRODUCT SPECIFICATION

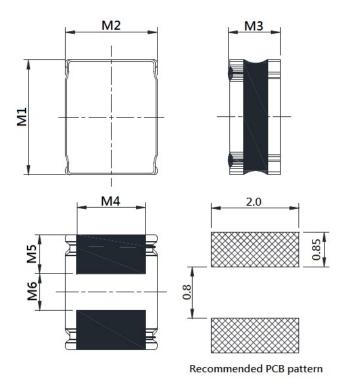
DOCUMENT NO. ENS000154640							
DESCRIPTION	DRAWN BY	DESIGNED BY	CHECKED BY	APPROVED BY			
CSMM2512D-XXXM-LRH	Zhuoling Tang	Shengjun Zhou	Shengjun Zhou	Dick Wang			



1. PART NUMBER IDENTIFICATION



2. MECHANICAL DIMENSION



UNIT: mm

	DIM.	TOL.
M1	2.5	±0.2
M2	2.0	±0.2
М3	1.3	MAX.
M4	1.5	±0.2
M5	0.8	±0.2
М6	0.8	±0.2

3. RATING TEMPERATURE

OPERATING TEMPERATURE RANGE (individual chip without packing): -40°C~+125°C (Including Self-heating). STORAGE TEMPERATURE RANGE (packaging conditions): -10°C~+40°C and RH 70% (Max.).

TITLE: POWER CHOKE (RoHS+H.F.)
CSMM2512D-XXXM-LRH

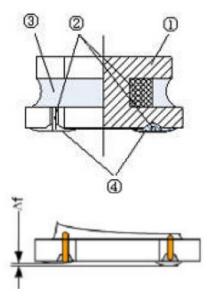
DOCUMENT NO. ENS000154640

SPEC REV.: A1 Page 1 of 8

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4. STRUCTURE



 \triangle f: Clearance between terminal and the surface of plate must be 0.1mm max when coil is placed on a flat plate.

5. MATERIAL LIST

ITEM	MATERIAL CATEGORY	MATERIAL TYPE
1	Core	Soft magnetic Metal
2	Wire	Polyurethane system enameled copper wire
3	Magnetic Glue	Epoxy resin and magnetic powder
4	Electrodes	Ag Ni Sn or Fe Ni Cu + Sn Alloy

TITLE : POWER CHOKE (RoHS+H.F.) CSMM2512D-XXXM-LRH DOCUMENT NO. ENS000154640

SPEC REV.: A1 Page 2 of 8

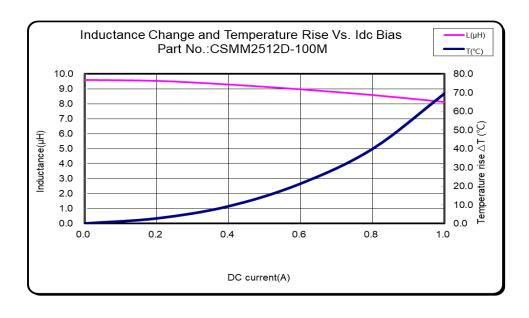


6. ELECTRICAL SPECIFICATION

Part number	Inductance (µH) ±20%	Test Frequency (MHz/V)	DC Resistance (Ω) MAX.	DC Resistance (Ω) TYP.	Isat (A) MAX.	Isat (A) TYP.	Irms (A) MAX.	Irms (A) TYP.
CSMM2512D-R24M-LRH	0.24	1/1	0.023	0.019	6.50	7.80	4.05	4.70
CSMM2512D-R33M-LRH	0.33	1/1	0.028	0.023	5.35	6.30	3.70	4.30
CSMM2512D-R47M-LRH	0.47	1/1	0.035	0.029	4.90	5.60	3.45	4.00
CSMM2512D-R68M-LRH	0.68	1/1	0.045	0.039	3.80	4.50	3.15	3.60
CSMM2512D-1R0M-LRH	1.0	1/1	0.054	0.048	3.60	4.20	3.00	3.40
CSMM2512D-2R2M-LRH	2.2	1/1	0.120	0.100	2.60	3.00	1.90	2.15
CSMM2512D-3R3M-LRH	3.3	1/1	0.215	0.175	1.70	2.10	1.50	1.80
CSMM2512D-4R7M-LRH	4.7	1/1	0.260	0.225	1.60	1.90	1.25	1.45
CSMM2512D-6R8M-LRH	6.8	1/1	0.366	0.305	1.20	1.40	0.95	1.10
CSMM2512D-100M-LRH	10	1/1	0.480	0.435	1.10	1.35	0.85	1.00

NOTE:

- 1. Rated current: Isat (max.) or Irms (max.), whichever is smaller.
- 2. Saturation Current: Max. Value, DC current at which the inductance drops less than 30% from its value without current; Typ. Value, DC current at which the inductance drops 30% from its value without current.
- 3. Irms: DC current that causes the temperature rise (\triangle T) from 20°C ambient. For Max. Value, \triangle T < 40°C; For Typ. Value, \triangle T is approximate 40°C.
- 4. The part temperature (ambient + temp. rise) should not exceed 125°C under worst case operating conditions. Circuit design, component placement, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.
- 5. Absolute maximum voltage: DC 25V
- 6. MSL: Level 1

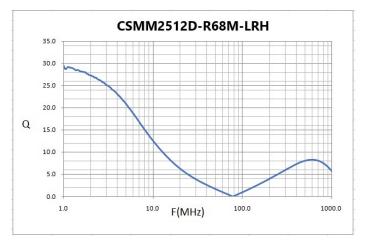


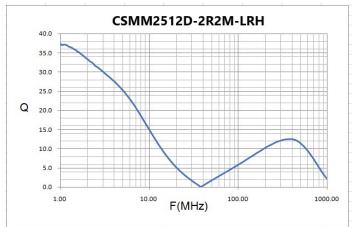
TITLE : POWER CHOKE (RoHS+H.F.) DOCUMENT NO. SPEC REV.: A1 Page 3 of 8

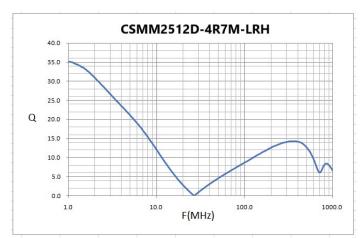
CSMM2512D-XXXM-LRH ENS000154640

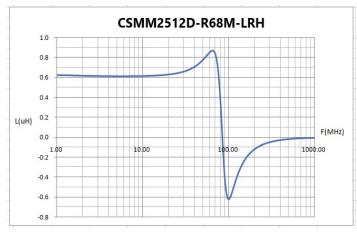


7. ELECTRICAL CURVE













TITLE: POWER CHOKE (RoHS+H.F.)
CSMM2512D-XXXM-LRH

DOCUMENT NO. ENS000154640

SPEC REV.: A1 Page 4 of 8

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8. RELIABILITY PERFORMANCE

Items	Requirements	Test Methods and Remarks					
Terminal Strength	No removal or split of the termination or other defects shall occur.	 Solder the inductor to the testing jig (glass epoxy board shown in Fing.7.1-1) using eutectic solder. Then apply a force in the direction of the arrow. 10N force. Keep time: 5s 					
Resistance to Flexure	No visible mechanical damage. R230 10 R230 Fig.7.2-1	 Solder the chip to the test jig (glass epoxy board) using eutectic solder. Then apply a force in the direction shown as Fig.7.2-1. Flexure: 2mm Pressurizing Speed: 0.5mm/sec Keep time: 30±1s Test board size: 100×40×1.0 Land dimension 					
Vibration	 No visible mechanical damage. Inductance change: Within ±10% 	 Solder the chip to the testing jig (glass epoxy board shown as the following figure) using eutectic solder The chip shall be subjected to a simple harmonic motion having total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range from 10 to 55Hz and return to 10Hz shall be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3 mutually perpendicular directions (total of 6 hours). 					
Temperature coefficient	Inductance change: Within ±20%	 Temperature: -40°C~+125°C With a reference value of +20°C , change rate shall be calculated 					
Solderability	90% or more of electrode area shall be coated by new solder	 The test samples shall be dipped in flux, and then immersed in molten solder. Solder temperature: 245±5°C Duration: 5±1sec. Solder: Sn/3.0Ag/0.5Cu Flux: 25% resin and 75% ethanol in weight Immersion depth: all sides of mounting terminal shall be immersed 					
Thermal Shock	1. No visible mechanical damage. 2. Inductance change: Within ±10% 125°C 30 min. 30 min. Temperature 30 min. 20sec. (max.) Fig.7.7-1	 Temperature and time: -40±3°C for 30±3 min→125°C for 30±3min, please refer to Fig.7.7-1. Transforming interval: Max, 20sec Tested cycle: 100 cycles The chip shall be stabilized at normal condition for 1~2 hours before measuring 					

TITLE : POWER CHOKE (RoHS+H.F.) CSMM2512D-XXXM-LRH DOCUMENT NO. ENS000154640

SPEC REV.: A1 Page 5 of 8

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Items	Requirements	Test Methods and Remarks
Resistance to Low Temperature	 No visible mechanical damage Inductance change: Within ±10% 	 Temperature and time: -40±3°C Duration: 1000±²⁴ hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
Resistance to High Temperature	1. No visible mechanical damage 2. Inductance change: Within ±10%	 Temperature and time: 125±2°C Duration: 1000±²⁴ hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
Damp Heat	1. No visible mechanical damage 2. Inductance change: Within ±10%	 Temperature and time: 60±2°C Humidity: 90% to 95% RH Duration: 1000±²⁴ hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
Loading Under Damp Heat	No visible mechanical damage Inductance change: Within ±10%	 Temperature and time: 60±2°C Humidity: 90% to 95% RH Applied current: Rated current Duration: 1000±²⁴ hours The chip shall be stabilized at normal condition for 1~2 hours before measuring
Loading at High Temperature	1. No visible mechanical damage 2. Inductance change: Within ±10%	 Temperature and time: 85±2°C Applied current: Rated current Duration: 1000±²⁴ hours The chip shall be stabilized at normal condition for 1~2 hours before measuring

TITLE: POWER CHOKE (RoHS+H.F.)
CSMM2512D-XXXM-LRH

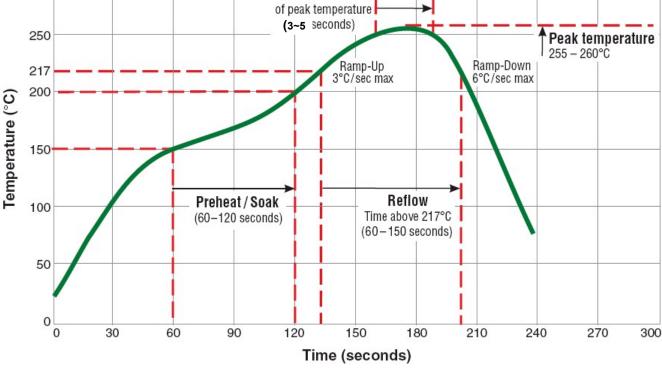
DOCUMENT NO. ENS000154640

SPEC REV.: A1 Page 6 of 8



9. REFLOW CHART

Typical RoHS Reflow Profile Time within 5°C of peak temperature (3~5 seconds)



TITLE: POWER CHOKE (RoHS+H.F.)
CSMM2512D-XXXM-LRH

DOCUMENT NO. ENS000154640

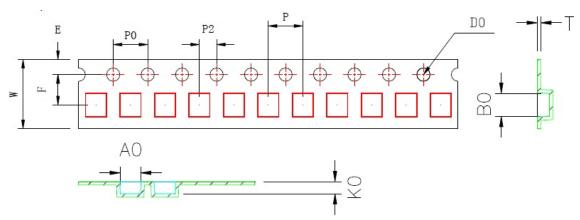
SPEC REV.: A1 Page 7 of 8

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10. PACKING

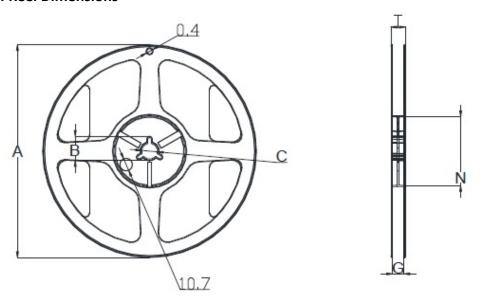
10-1. Carrier Tape Dimensions:



UNIT: mm

	W	Α0	В0	ко	Р	F	E	D0	P0	P2	Т
DIM.	8.00	2.35	2.65	1.4	4.00	3.5	1.75	1.50	4.00	2.00	0.25
TOL.	±0.3	±0.1	±0.1	±0.1	±0.1	±0.1	±0.1	+0.1	±0.1	±0.1	±0.05

10-2. Reel Dimensions



UNIT:mm

Туре	Α	В	С	G	N	Т
8 mm	178	20.7±0.8	13±0.4	9	60	10.8

10-3. Packaging Quantity:

2KPCS/ Reel ,20KPCS/ Inner Box ,80KPCS/ Outer Box

TITLE : POWER CHOKE (RoHS+H.F.) DOCUMENT NO.
CSMM2512D-XXXM-LRH ENS000154640 SPEC REV.: A1 Page 8 of 8